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Date: May 20, 2004

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>				ATTY. DOCKET NO. EWW-005XX		APPLICATION NO. 09/621,188	
				APPLICANT: Jeffrey Delaney et al.		Technology Center 2100	
FILING DATE July 21, 2000		TC ART UNIT 2155					
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE	
Lw	US 6,631,258	10/7/2003	Chow et al.	455	417	12/13/1999	
Lw	US 6,597,688	7/22/2003	Narasimhan et al.	370	353	6/12/1998	
Lw	US 6,647,257	11/11/2003	Owensby	455	414.1	12/10/1998	
Lw	US 6,630,883	10/7/2003	Amin et al.	340	7.29	12/2/1997	
Lw	US 6,498,835	12/24/2002	Skladman et al.	379	88.12	2/29/2000	
Lw	US 6,442,592	8/27/2002	Alumbaugh et al.	709	206	12/11/1998	
Lw	US 6,442,250	8/27/2002	Troen-Krasnow et al.	379	93.15	8/22/2000	
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
Lw	WO 03/021796	3/13 2003	PCT	—	—		
Lw	WO 02/087095	10/31/2002	PCT	—	—		
Lw	WO 02/37393	5/10/2002	PCT	—	—		
OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER <i>Lf-ch</i>				DATE CONSIDERED 7/20/04			
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(REV. 05/03) DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>	ATTY. DOCKET NO. EWW-005XX	APPLICATION NO. 09/621,188 RECEIVED MAY 26 2004
	APPLICANT: Jeffrey Delaney et al. Technology Center 2100	
	FILING DATE July 21, 2000	TC ART UNIT 2155

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
fw	US 6,438,584	8/20/2002	Powers	709	206	3/7/2000
↓	US 6,363,415	3/26/2002	Finney et al.	709	206	8/11/2000
↓	US 6,363,414	3/26/2002	Nicholls et al.	709	206	12/29/1998
↓	US 6,072,862	6/6/2000	Srinivasan	379	100.08	7/2/1996
↓	US 6,034,970	3/7/2000	Levac et al.	370	466	7/2/1997
↓	US 6,021,433	2/1/2000	Payne et al.	709	219	1/24/1997
↓	US 6,014,429	1/11/2000	LaPorta et al.	379	88.15	8/12/1996

FOREIGN PATENT DOCUMENTS

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fw	WO 01/69385	9/20/2001	PCT	—	—		
↓	WO 01/67284	9/13/2001	PCT	—	—		
↓	WO 01/58119	8/9/2001	PCT	—	—		

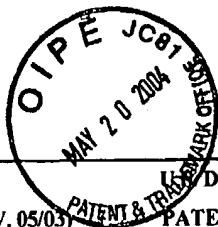
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
fw	US 5,978,837	11/2/1999	Foladare et al.	709	207	9/27/1996
	US 5,850,594	12/15/1998	Cannon et al.	455	31.3	8/26/1996
	US 5,841,966	11/24/1998	Irribarren	395	200.36	9/9/1996
	US 5,838,252	11/17/1998	Kikinis	340	825.44	9/9/1996
	US 5,818,447	10/6/1998	Wolf et al.	345	335	6/6/1996
	US 5,796,394	8/18/1998	Wicks et al.	345	329	9/23/1997
	US 5,794,039	8/11/1998	Guck	395	683	12/18/1996

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fw	WO 00/48351	8/17/2000	PCT	—	—		

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE
(REV. 05/03)

ATTY. DOCKET NO.
EWW-005XX

APPLICATION NO.
09/621,188

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APPLICANT:
Jeffrey Delaney et al.

Technology Center 2100

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July 21, 2000

TC ART UNIT
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
fw	US 5,758,088	5/26/1998	Bezaire et al.	395	200.62	7/24/1997
	US 5,740,231	4/14/1998	Cohn et al.	379	89	9/16/1994
	US 5,706,334	1/6/1998	Balk et al.	379	67	2/23/1995
	US 5,673,256	9/30/1997	Maine	370	271	7/25/1995
	US 5,287,498	2/15/1994	Perelman et al.	395	600	4/2/1991
	US 5,179,660	1/12/1993	Devany et al.	395	200	5/15/1989
	US 2003/0208545	11/6/2003	Eaton et al.	709	206	5/1/2002

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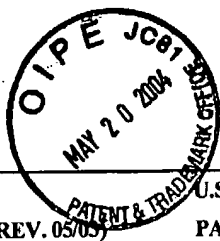
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>fw</i>	US 2003/0208363	11/6/2003	Thurnher	705	1	9/10/2002
	US 2003/0204556	10/30/2003	Bernard	709	200	1/23/2003
	US 2003/0195937	10/16/2003	Kircher, Jr. et al.	709	207	4/16/2002
	US 2003/0177277	9/18/2003	Dascalu	709	313	3/15/2002
	US 2003/0163536	8/28/2003	Pettine, Jr.	709	206	8/16/2002
	US 2003/0161448	8/28/2003	Parolkar et al.	379	88.17	2/27/2002
	US 2003/0154257	8/14/2003	Hantsch et al.	709	207	2/14/2002

FOREIGN PATENT DOCUMENTS

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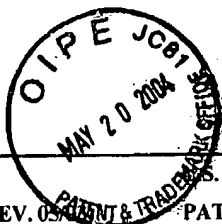
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U.S. DEPARTMENT OF COMMERCE (REV. 05-01-00) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>	ATTY. DOCKET NO. EWW-005XX	APPLICATION NO. 09/621,188 RECEIVED MAY 26 2004
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EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
Lw	US 2003/0126216	7/3/2003	Avila et al.	709	206	9/6/2002
	US 2003/0110225	6/12/2003	Billadeau	709	206	10/11/2002
	US 2003/0088465	5/8/2003	Monteverde	705	14	7/24/2000
	US 2003/0088434	5/8/2003	Blechman	705	1	8/1/2002
	US 2002/0177456	11/28/2002	Kimoto et al.	455	466	5/10/2002
	US 2002/0165923	11/7/2002	Prince	709	206	4/17/2001
	US 2002/0161841	10/31/2002	Kinnunen	709	206	4/24/2002

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EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
fw	US 2002/0160794	10/31/2002	Tisserand et al	455	466	12/20/2000
	US 2002/0156896	10/24/2002	Lin et al.	709	227	2/9/2001
	US 2002/0102993	8/1/2002	Hendrey et al.	455	456	7/5/2001
	US 2002/0077130	6/20/2002	Owensby	455	466	12/10/1998
	US 2002/0069116	6/6/2002	Ohashi et al.	705	26	12/1/2000
	US 2002/0065890	5/30/2002	Barron	709	206	11/29/2000
	US 2002/0065889	5/30/2002	Macor	709	206	4/16/1998

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						YES	NO

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APPLICANT:
Jeffrey Delaney et al. Technology Center 2100FILING DATE
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
Lw	US 2001/0016868	8/23/2001	Nakamura et al.	709	202	5/1/2001
Lw	US 2001/0005859	6/28/2001	Okuyama et al.	709	245	1/30/2001
Lw	US H2079 H	9/2/2003	Menon et al.	370	329	9/29/2000

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DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO

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